

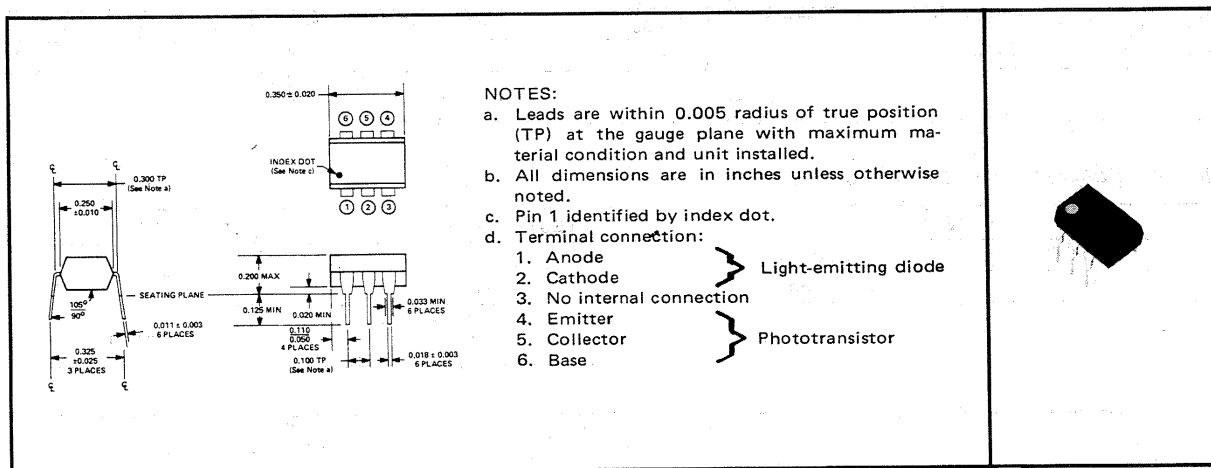
TYPE TIL112 OPTICALLY COUPLED ISOLATOR

TYPE TIL112
BULLETIN NO. DLS-7111547, SEPTEMBER 1971

- Gallium Arsenide Diode Light Source Optically Coupled to a Silicon N-P-N Phototransistor
- High Direct-Current Transfer Ratio
- Base Lead Provided for Conventional Transistor Biasing
- High-Voltage Electrical Isolation . . . 1.5-kV Rating
- Plastic Dual-In-Line Package
- High-Speed Switching: $t_r = 2 \mu s$, $t_f = 2 \mu s$ Typical

mechanical data

The package consists of a gallium arsenide light-emitting diode and an n-p-n silicon phototransistor mounted on a 6-lead frame encapsulated within an electrically nonconductive plastic compound. The case will withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high-humidity conditions. Unit weight is approximately 0.52 grams.



absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

Input-to-Output Voltage	±1.5 kV
Collector-Base Voltage	30 V
Collector-Emitter Voltage (See Note 1)	20 V
Emitter-Collector Voltage	4 V
Emitter-Base Voltage	4 V
Input-Diode Reverse Voltage	3 V
Input-Diode Continuous Forward Current at (or below) 25°C Free-Air Temperature (See Note 2)	60 mA
Continuous Power Dissipation at (or below) 25°C Free-Air Temperature:	
Light-Emitting Diode (See Note 3)	100 mW
Phototransistor (See Note 4)	150 mW
Storage Temperature Range	-55°C to 150°C
Lead Temperature 1/16 inch from case for 10 seconds	240°C

- NOTES: 1. This value applies when the base-emitter diode is open-circuited.
 2. Derate linearly to 100°C free-air temperature at the rate of 0.8 mA/°C.
 3. Derate linearly to 100°C free-air temperature at the rate of 1.33 mW/°C.
 4. Derate linearly to 100°C free-air temperature at the rate of 2 mW/°C.

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electrical characteristics at 25°C free-air temperature

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{(BR)CBO}$	Collector-Base Breakdown Voltage	$I_C = 10 \mu A$, $I_E = 0$, $I_F = 0$	30			V
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage	$I_C = 1 mA$, $I_B = 0$, $I_F = 0$	20			V
$V_{(BR)EBO}$	Emitter-Base Breakdown Voltage	$I_E = 10 \mu A$, $I_C = 0$, $I_F = 0$	4			V
$I_{C(on)}$	On-State Collector Current	Phototransistor Operation $V_{CE} = 5 V$, $I_B = 0$, $I_F = 10 mA$	0.2	2		mA
		Photodiode Operation $V_{CB} = 5 V$, $I_E = 0$, $I_F = 10 mA$	2	10		μA
$I_{C(off)}$	Off-State Collector Current	Phototransistor Operation $V_{CE} = 5 V$, $I_B = 0$, $I_F = 0$		1	100	nA
		Photodiode Operation $V_{CB} = 5 V$, $I_E = 0$, $I_F = 0$		0.1	50	nA
h_{FE}	Transistor Static Forward Current Transfer Ratio	$V_{CE} = 5 V$, $I_C = 10 mA$, $I_F = 0$	50	200		
V_F	Input Diode Static Forward Voltage	$I_F = 10 mA$		1.2	1.5	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C = 2 mA$, $I_B = 0$, $I_F = 50 mA$			0.5	V
R_{in-out}	Input-to-Output Internal Resistance	$V_{in-out} = \pm 1.5 kV$, See Note 5	10^{11}			Ω
C_{in-out}	Input-to-Output Capacitance	$V_{in-out} = 0$, $f = 1 MHz$, See Note 5		1	2	pF

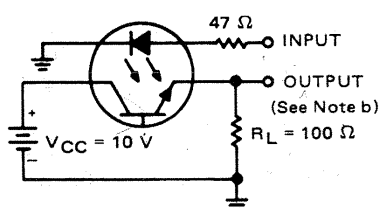
NOTE 5: These parameters are measured between both input diode leads shorted together and all the phototransistor leads shorted together.

switching characteristics at 25°C free-air temperature

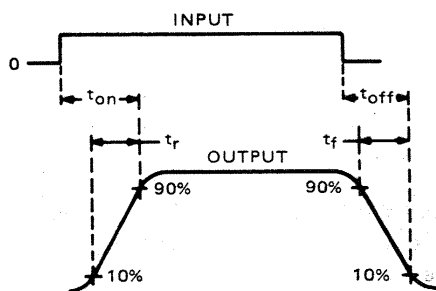
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_r	Rise Time	Phototransistor Operation $V_{CC} = 10 V$, $I_{C(on)} = 2 mA$, $R_L = 100 \Omega$, See Test Circuit A of Figure 1		2	15	μs
t_f	Fall Time			2	15	
t_r	Rise Time	Photodiode Operation $V_{CC} = 10 V$, $I_{C(on)} = 20 \mu A$, $R_L = 1 k\Omega$, See Test Circuit B of Figure 1		1		μs
t_f	Fall Time			1		

PARAMETER MEASUREMENT INFORMATION

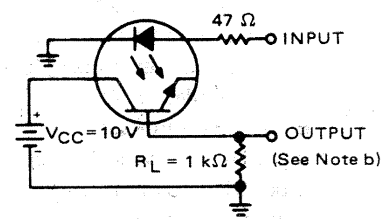
Adjust amplitude of input pulse for:
 $I_{C(on)} = 2 mA$ (Test Circuit A) or
 $I_{C(on)} = 20 \mu A$ (Test Circuit B)



TEST CIRCUIT A
PHOTOTRANSISTOR OPERATION



VOLTAGE WAVEFORMS



TEST CIRCUIT B
PHOTODIODE OPERATION

- NOTES: a. The input waveform is supplied by a generator with the following characteristics: $Z_{out} = 50 \Omega$, $t_r \leq 15 ns$, duty cycle $\approx 1\%$, $t_w = 100 \mu s$.
- b. The output waveform is monitored on an oscilloscope with the following characteristics: $t_r \leq 12 ns$, $R_{in} \geq 1 M\Omega$, $C_{in} \leq 20 pF$.

FIGURE 1—SWITCHING TIMES

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TYPICAL CHARACTERISTICS

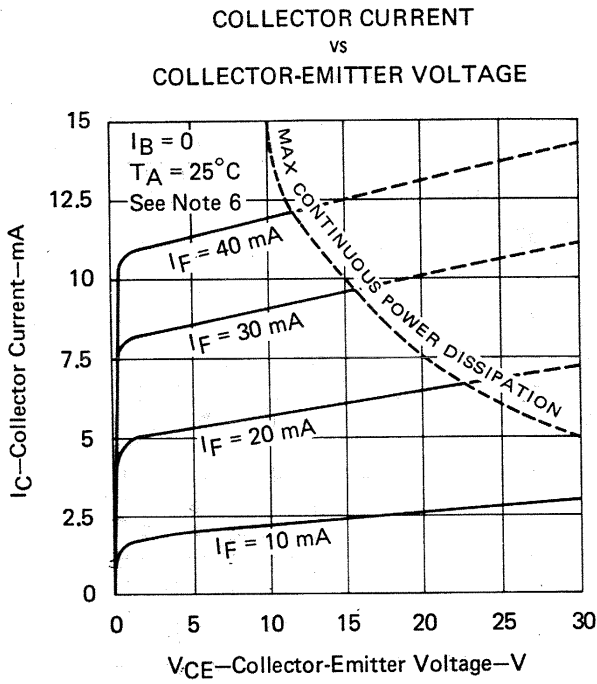


FIGURE 2

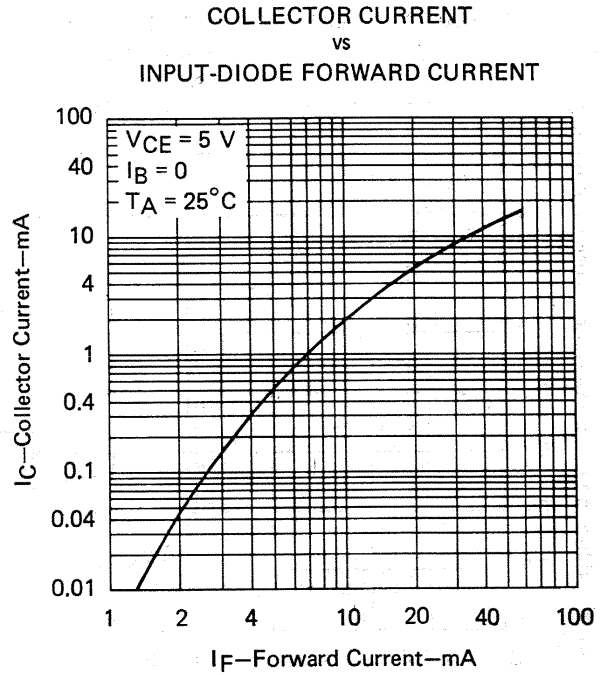


FIGURE 3

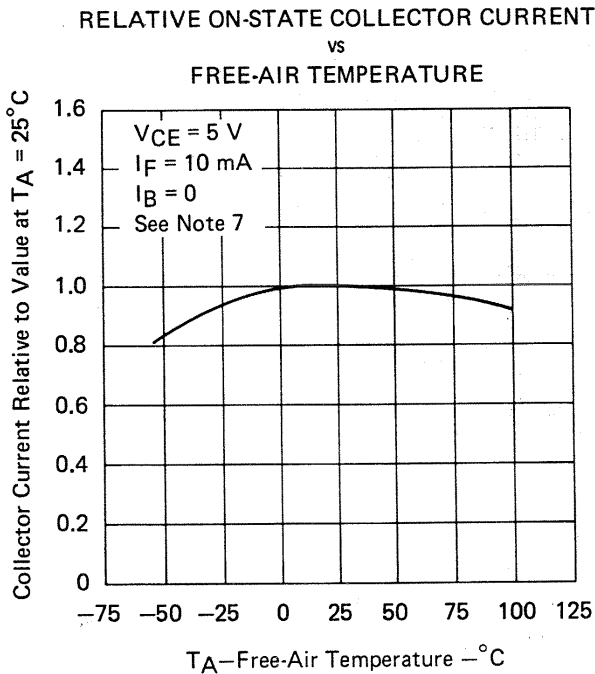


FIGURE 4

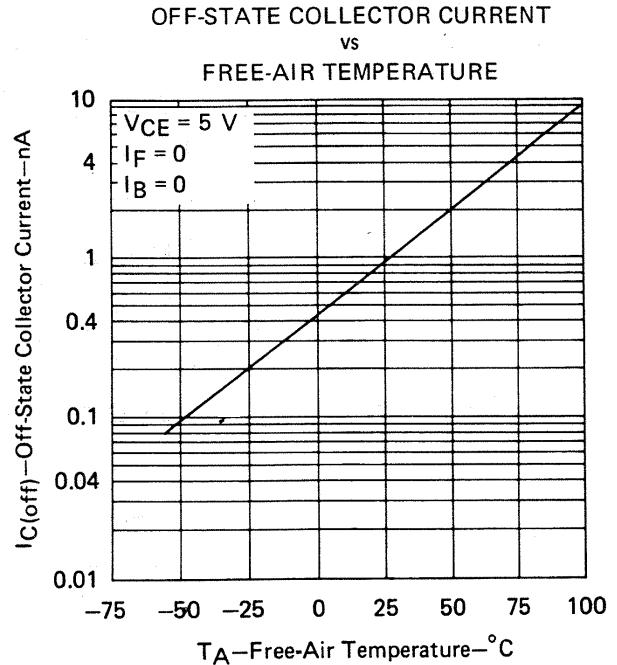


FIGURE 5

NOTES: 6. Pulse operation of input diode is required for operation beyond limits shown by dotted line.
7. These parameters were measured using pulse techniques $t_w = 1\text{ ms}$, duty cycle $\leq 2\%$.

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TYPICAL CHARACTERISTICS

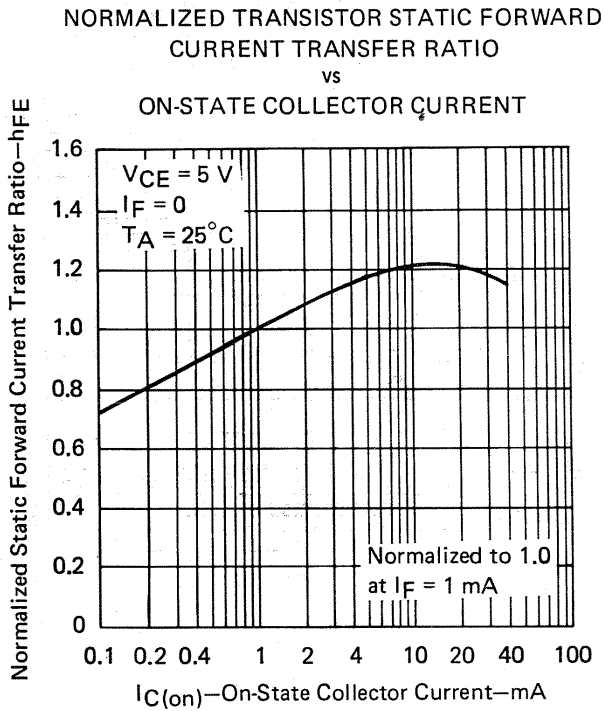


FIGURE 6

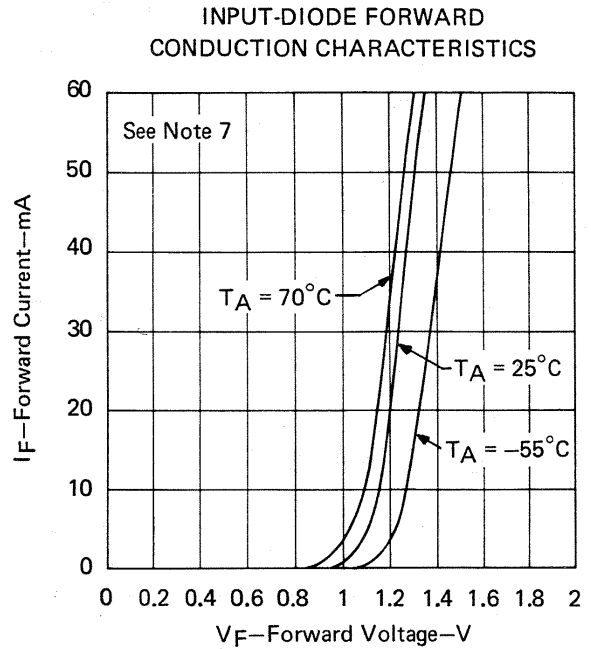


FIGURE 7

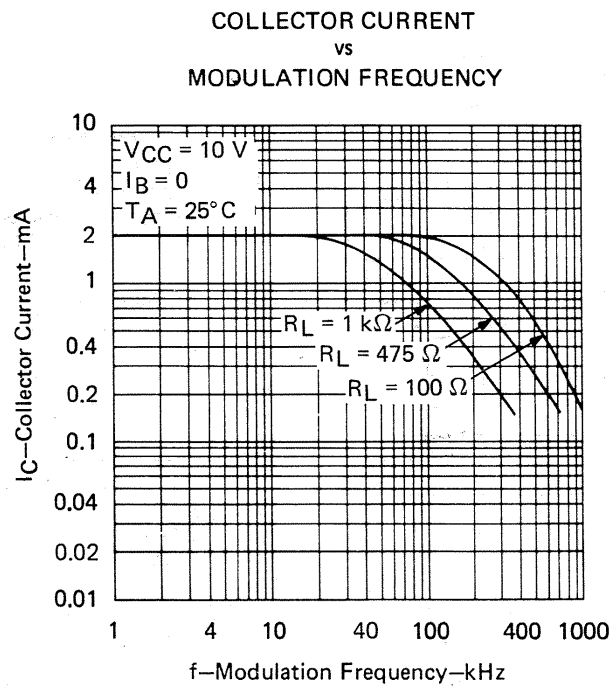


FIGURE 8

NOTE 7: These parameters were measured using pulse techniques $t_w = 1\text{ ms}$, duty cycle $\leq 2\%$.

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